



DIM900ESM45-F000

Data

Single Switch IGBT Module

DS5872-1.0 October 2005 (LN24283)

FEATURES

- 10µs Short Circuit Withstand
- Soft Punch Through Silicon
- Lead Free construction
- Isolated MMC Base with AlN Substrates
- High Thermal Cycling Capability

APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 600V to 6500V and currents up to 3600A.

The DIM900ESM45-F000 is a single switch 4500V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10us short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM900ESM45-F000

Note: When ordering, please use the complete part number

KEY PARAMETERS

V CES		4500V
V CE(sat) *	(typ)	3.0V
Iс	(max)	900A
I C(PK)	(max)	1800A
*(and not the av

*(measured at the power busbars and not the auxiliary terminals)

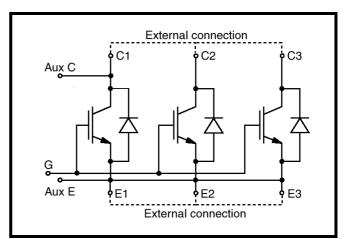
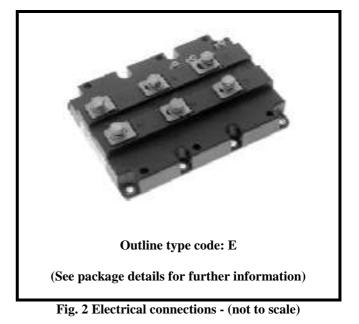


Fig. 1 Single switch circuit diagram



ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25℃ unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	$V_{GE} = 0V$	4500	V
V _{GES}	Gate-emitter voltage		±20	V
I _C	Continuous collector current	T _{case} =90 °C	900	А
I _{C(PK)}	Peak collector current	1ms, T _{case} =115 °C	1800	А
P _{max}	Max.transistor power dissipation	$T_{case} = 25 \ ^{\circ}C, T_{j} = 150 \ ^{\circ}C$	15.6	kW
I ² t	Diode I ² t value (Diode arm)	$V_{R} = 0, t_{p} = 10 \text{ms}, T_{vj} = 125 ^{\circ}\text{C}$	TBD	kA ² s
V_{isol}	Isolation voltage	Commoned terminals to base plate. AC RMS,1 min,50Hz	6000	kV
Q_{PD}	Partial discharge	IEC1287.V ₁ =3750V, V ₂ =2750V, 50Hz RMS	10	pC

THERMAL AND MECHANICAL RATINGS

Internal insulation material:	AlN
Baseplate material:	AlSiC
Creepage distance:	29mm
Clearance:	20mm
CTI (Critical Tracking Index)	175

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R _{th(j-c)}	Thermal resistance -transistor	Continuous dissipation - junction to case		-	8	°C/kW
R _{th(j-c)}	Thermal resistance -diode	Continuous dissipation - junction to case		-	16	°C/kW
R _{th(c-h)}	Thermal resistance -case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)		-	6	°C/kW
Tj	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T_{stg}	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting M6	-	-	5	Nm
		Electrical connections -M4	-	-	2	Nm
		Electrical connections -M8	-	-	10	Nm

ELECTRICAL CHARACTERISTICS

T case = 25° C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Ices	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}$			3	mA
		$V_{GE}=0V, V_{CE}=V_{CES}, T_{case}=125 \text{ °C}$			90	mA
Iges	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			8	uA
$V_{\text{GE(TH)}}$	Gate threshold voltage	$I_{C}=120 \text{mA}, V_{GE}=V_{CE}$	5.5	6.5	7.0	V
$V_{\text{CE(sat)}}\dagger$	Collector-emitter saturation voltage	V _{GE} =15V,Ic=900A		3.0		V
		V _{GE} =15V,Ic=900A,T _{VJ} =125 °C		3.5		V
IF	Diode forward current	DC			900	А
IFM	Diode maximum forward current	$t_p = 1 ms$			1800	А
VF	Diode forward voltage	IF=900A		3.5		V
		IF=900A,T _{VJ} =125 °C		3.9		V
Cies	Input capacitance	Vce=25V,Vge=0V,f=1MHz		200		nF
Cres	Reverse transfer capacitance	Vce=25V,Vge=0V,f=1MHz		2.4		nF
Цм	Module inductance			10		nH
Rint	Internal resistance			90		μΩ
SC _{Data}	Short circuit.I SC	$T_j \le 125 \ ^{\circ}C, V_{CC} \le 3000V, I_1$		4200		А
		t p=10 us, I 2 V _{CE(max})=V _{CES} -L*.di/dt IEC 60747-9		3800		A

Note:

 $\dagger_{\mbox{Measured}}$ at the power busbars and not the auxiliary terminals

^{*}L is the circuit inductance + L M

Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures

ELECTRICAL CHARACTERISTICS

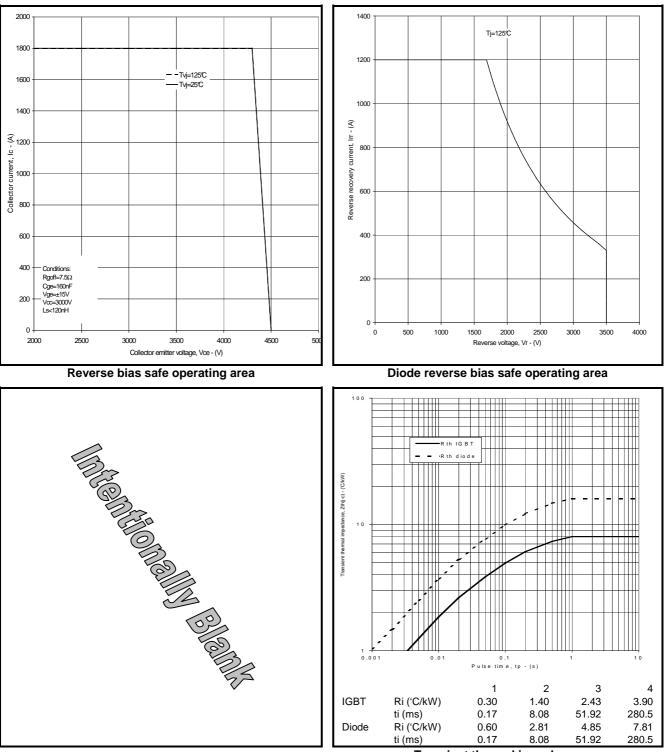
 $T_{\text{case}} = 25^{\circ}C$ unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	I _C =900A		6.0		us
t _f	Fall time	$V_{GE} = \pm 15 V$		250		ns
E _{OFF}	Turn-off energy loss	V _{CE} =2250V		1900		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 3.3\Omega R_{G(OFF)} = 7.5\Omega$		900		ns
t _r	Rise time	C _{ge} =160nF		250		ns
E _{ON}	Turn-on energy loss	L ~200nH		4500		mJ
Qg	Gate charge			TBD		uC
Q _{rr}	Diode reverse recovery charge	$I_{\rm F} = 900 {\rm A}, {\rm V}_{\rm CE} = 2250 {\rm V},$		TBD		uC
I _{rr}	Diode reverse recovery current	$dI_{\rm F}/dt = 3600 {\rm A/us}$		TBD		А
E _{rec}	Diode reverse recovery energy			750		mJ

$T_{\text{case}}\!=\!125^\circ C$ unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
$t_{d(off)}$	Turn-off delay time	I _C =900A		6.0		us
t _f	Fall time	$V_{GE} = \pm 15 V$		250		ns
E _{OFF}	Turn-off energy loss	V _{CE} =2250V	-	2250		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 3.3\Omega R_{G(OFF)} = 7.5\Omega$		700		ns
t _r	Rise time	C _{ge} =160nF		200		ns
E _{ON}	Turn-on energy loss	L~200nH		5200		mJ
Q _{rr}	Diode reverse recovery charge	$I_{\rm F} = 900 \text{A}, V_{\rm CE} = 2250 \text{V},$		TBD		uC
I _{rr}	Diode reverse recovery current	$dI_F/dt = 3600A/us$		TBD		А
E _{rec}	Diode reverse recovery energy			1150		mJ





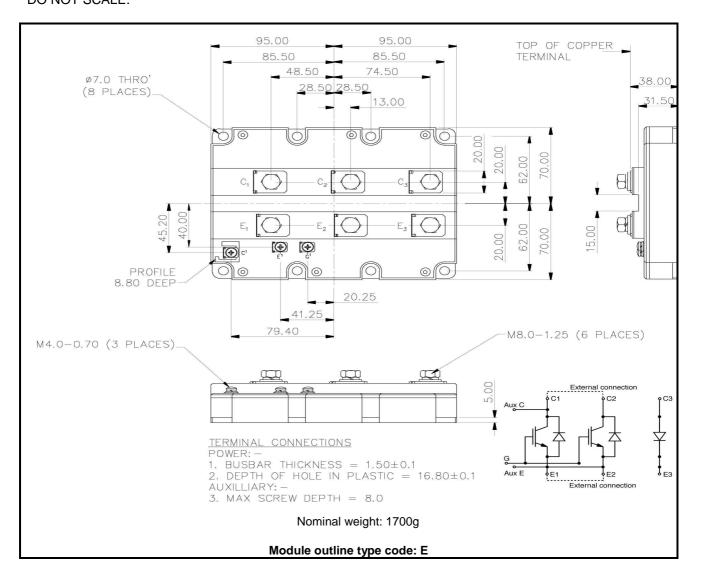
Transient thermal impedance

Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures



PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.





POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

HEATSINKS

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.



http://www.dynexsemi.com

e-mail: power_solutions@dynexsemi.com

HEADQUARTERS OPERATIONS

CUSTOMER SERVICE

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Target Information: This is the most tentative form of information and represents a very preliminary specification. No actual design work on the product has been started.

Preliminary Information: The product is in design and development. The datasheet represents the product as it is understood but details may change.

Advance Information: The product design is complete and final characterisation for volume production is well in hand.

No Annotation: The product parameters are fixed and the product is available to datasheet specification.

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